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Application/Control No.	Applicant(s)/Patent under Reexamination
09/587,960	YUNG ET AL.
Examiner	Art Unit
DANH C. LE	2617

SEARCHED				
Class	Subclass	Date	Examiner	
455	430 429	12/15/06	DCL 1	
	427			
370	316 310			
	210			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	·		-
Interfere	nce Search	12/15/06	DCL.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Name Search (Check for double patenting)	4 4 06	DCL
EAST Search updated (05, USPUB, JPU, EPO DERWENT)	12 15 06	DU_
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